

INFORMATION DISCLOSURE CITATION IN AN APPLICATION

(Use several sheets if necessary)

Docket No.
378-21-006

Application Number
09/783,831

Applicant
JAMES D. PARSONS

Filing Date
FEBRUARY 14, 2001

Group Art Unit
2878 2632



U.S. PATENT DOCUMENTS

[illegible]

FOREIGN PATENT DOCUMENTS

	Document Number							Date	Country	Class	Subclass	Translation	
												Yes	No

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

Q.W.S	1	SensArray Corporation, <u>Process Probe 1840</u> , Data Sheet, 1998
	2	SensArray Corporation, <u>Process probe 1530</u> , Data Sheet, 1998
↓	3	SensArray Corporation, <u>Process Probe 1630</u> , Data Sheet, 1998
	4	SensArray Corporation, <u>1700 Series</u> , Data Sheet, 1994
↓	5	Schott Corporation, <u>BOROFLOAT Borosilicate Float Glass</u> , Data Sheet
	6	Schott Corporation, <u>D 163 Thin Borosilicate Glass</u> , Data Sheet
Examiner		Date Considered
Dawitt W. Gols		6/8/04

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FORM PTO-1449 (Modified)

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Examiner

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FOREIGN PATENT DOCUMENTS

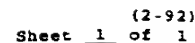
[illegible]

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

DWL	7	Schott Corporation, <u>AF 45 Thin Borosilicate Glass, Data Sheet</u>
	8	SansArray Corporation, <u>Using SensArray Temperature Instrumented Wafers Series 1501, Type R Thermocouples, 6/10/93</u>
4	9	SansArray Corporation, <u>Using SensArray Temperature Instrumented Wafers Series 1501, Type K Thermocouples, 2/5/94</u>

Examiner <i>Daniel J. Goss</i>	Date Considered <i>6/8/04</i>
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